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Front Matter: Volume 8321

, "Front Matter: Volume 8321," Proc. SPIE 8321, Seventh International Symposium on Precision Engineering Measurements and Instrumentation, 832101 (12 December 2011); doi: 10.1117/12.920295

SPIE.

Event: Seventh International Symposium on Precision Engineering Measurements and Instrumentation, 2011, Yunnan, China

PROCEEDINGS OF SPIE

Seventh International Symposium on Precision Engineering Measurements and Instrumentation

**Kuang-Chao Fan
Rong-Sheng Lu
Man Song**
Editors

**7–11 August 2011
Lijiang, China**

Sponsored by
International Committee on Measurements and Instrumentation
National Natural Science Foundation of China (China)

Organized by
Hefei University of Technology (China)
Beijing Information Science and Technology University (China)
National Taiwan University (Taiwan, China)
Harbin Institute of Technology (China)

Published by
SPIE

Volume 8321
Part One of Two Parts

Proceedings of SPIE, 0277-786X, v. 8321

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

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Please use the following format to cite material from this book:

Author(s), "Title of Paper," in *Seventh International Symposium on Precision Engineering Measurements and Instrumentation*, edited by Kuang-Chao Fan, Rong-Sheng Lu, Man Song, Proceedings of SPIE Vol. 8321 (SPIE, Bellingham, WA, 2011) Article CID Number.

ISSN 0277-786X

ISBN 9780819479402

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA

Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445

SPIE.org

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Printed in the United States of America.

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Introduction

The International Symposium on Precision Engineering Measurement and Instrumentation (ISPEMI) 2011 took place in Lijiang, China on 7–11 August 2011. Its approximately 230 attendees from 18 countries were treated to five days of talks, posters, technical exhibits, and special events, with ample opportunities for discussing measurement science and technology in precision engineering, making personal and scientific connections, and finding out the latest trends in our rapidly evolving interdisciplinary field. The ISPEMI program was organized into thirteen thematic sessions, and the chairs of each solicited manuscripts from their respective oral and poster presenters. These were compiled into the 7th ISPEMI proceedings volume.

The ISPEMI 2011 presentations were thematically diverse, as indicated by the session titles: Precision Theory and Uncertainty Evaluation, Micro/Nano Coordinate Measurement, Surface Measurement and Characterization, Optical Precision Measurement, etc. As you read this volume, you will encounter interesting studies for advanced dimensional, geometrical, micro structures, and material properties measurements using different methods, such as optical, tactile, electrical, NDT, etc. Such breadth and variety nicely illustrates the diversity of research in this exciting field. We hope that as you read this, you will be inspired to (and continue to) actively contribute to measurement and instrumentation research!

**Kuang-Chao Fan
Rong-Sheng Lu
Man Song**